## Notice of References Cited Application/Control No. 10/590,620 Examiner Henok Legesse Applicant(s)/Patent Under Reexamination ZAPKA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,865,123 A	09-1989	Kawashima et al.	.165/104.33
*	В	US-6,503,964 B2	01-2003	Smith et al.	523/137
*	C	US-2005/0062799 A1	03-2005	Kitahara et al.	347/040
	D	US-			
	Е	US-			
	F	US-		,	
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-	,		
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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